Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/535,001	ALLEN, JOHN AUBREY	
Examiner	Art Unit	
Pablo N. Tran	2618	

Subclass	Date	
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
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